

BCT642 Low-Power, Three-Port, High-Speed MIPI Switch

GENERAL DESCRIPTION

The BCT642 is a bi-directional, low-power, highspeed analog switch. The pin out is designed to ease differential signal layout and is configured as a triple-pole, double-throw switch (TPDT). The BCT642 is optimized for switching between two MIPI devices, such as cameras or LCD displays and on-board Multimedia Application Processors (MAP).

The BCT642 is compatible with the requirements of Mobile Industry Processor Interface (MIPI). The low-capacitance design allows the BCT642 to switch signals that exceed 500MHz in frequency. Superior channel-to-channel crosstalk immunity minimizes interference and allows the transmission of high-speed differential signals and single-ended signals, as described by the MIPI specification. BCT642 is a direct replacement for FSA642.

FEATURES

- Low On Capacitance:7.0pF Typical
- Low On Resistance:7.0Ω Typical
- Differential -3db Bandwidth:1.5GHz
- 24-Lead QFN (2.5 x 3.4mm) Package

APPLICATIONS

Dual Camera Applications for Cell Phones Dual LCD Applications for Cell Phones, Digital Camera Displays, and Viewfinders

ORDERING INFORMATION

Order Number	Package Type	Temperature Range	Marking	QTY/Reel
BCT642EGG-TR	QFN-24(2.5 mmx 3.4 mm)	-40°C to +85°C	642	3000

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TYPICAL OPERATING CIRCUIT





Fiaure 1.	Application	Block	Diagram
	/		=

ABSOLUTE MAXIMUM RATINGS

Supply Voltage (Vcc)0.5V	to +5.25V
DC Input Voltage (SEL, /OE) ⁽¹⁾ 0.4	5V to VccV
DC Switch I/O Voltage0.5V to	V _{CC} +0.3V
DC Input Diode Current	50mA
DC Output Current	50mA
Storage Temperature Range65°C	to +150℃
Junction Temperature	150 ℃
Operating Temperature Range40°	C to +85℃
Lead Temperature (Soldering, 10 sec)	260 ℃
ESD Susceptibility	
All Pins	4KV

CAUTION

This integrated circuit can be damaged by ESD if you don't pay attention to ESD protection. Broadchip recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage. ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

Broadchip reserves the right to make any change in circuit design, specification or other related things if necessary without notice at any time. Please contact Broadchip sales office to get the latest datasheet

RECOMMENDED OPERATING CONDTIONS

The Recommended Operating Conditions table defines the conditions for actual device operation. Recommended operating conditions are specified to ensure optimal performance to the datasheet specifications.

Symbol	Parameter	Min.	Max.	Unit
V _{cc}	Supply Voltage	2.65	4.3	V
V _{CTRL}	Control Input Voltage(SEL,/OE) ⁽²⁾	0	V _{cc}	V
V _{SW}	Switch I/O Voltage	-0.5	V _{cc}	V
TA	Operating Temperature	-40	+85	°C

Notes:

1. The input and output negative ratings maybe exceed if the input and output diode current ratings are observed.

2. The control input must be held HIGH or LOW; it must not float.

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PIN CONFIGURATION





PIN DESCRIPTION

PIN	NAME	FUNCTION
1, 2	CLKP, CLKN	Clock Path (Common)
3, 4	D1P, D1N	Data Path 1 (Common)
5, 6	D2P, D2N	Data Path2 (Common)
7, 24	NC	No Connect (Float)
8	/OE	Output Enable (Active Low)
9	GND	Ground
10	VCC	Power
11	SEL	Select (0=A,1=B)
12, 13	DA2N, DA2P	Data Path (A2)
14, 15	DA1N, DA1P	Data Path (A1)
16, 17	CLKAN, CLKAP	Clock Path (A)
18, 19	DB2N, DB2P	Data Path (2B)
20, 21	DB1P, DB1N	Data Path (1B)
22, 23	CLKBP, CLKBN	Clock Path (B)

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FUNCTIONAL DIAGRAM





TRUTH TABLE

SEL	/OE	Function
Don't care	HIGH	Disconnect
LOW	LOW	D1, D2, CLK=DA1, DA2, CLKA
HIGH	LOW	D1, D2, CLK=DB1, DB2, CLKB

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DC ELECTRICAL CHARACTERISTICS

(All typical values are $T_A = 25^{\circ}$ C, unless otherwise specified.)

PARAMETER	SYM	CONDITIONS	V _{cc} (V)	MIN	TYP	MAX	UNITS
Clamp Diode Voltage	VIK	I _{IN} =-18mA	2.775			-1.2	V
Control Input Leakage	I _{IN}	V _{SW} =0 to 4.3V	4.3	-1		1	uA
Input Voltage High	VIH	V_{IN} =0 to V_{CC}	2.65 to 2.775	1.3			V
			4.3	1.7			V
Input Voltage Low	VIL	$V_{IN}=0$ to V_{CC}	2.65 to 2.775			0.5	V
Off-State Leakage	loz	A,B=+0.3V to V _{CC} -0.3	4.3	-2		2	uA
Quiescent Supply Current	Icc	V _{CNTRL} =0 or V _{CC} , I _{OUT} =0	4.3			1	uA
Increase in Icc Current Per		\/1_8\/	2 775			15	
Control Voltage and V_{CC}	ICCT	V CNTRL= 1.0 V	2.775			1.5	uA

DC ELECTRICAL CHARACTERISTICS, LOW-SPEED MODE

(All typical values are $T_A = 25^{\circ}C$, unless otherwise specified.)

PARAMETER	SYM	CONDITIONS	V _{cc} (V)	MIN	TYP	MAX	UNITS
LS Switch On Resistance ⁽³⁾	R _{ON}	V _{SW} =1.2V,I _{ON} =-10mA	2.65		10	14	Ω
LS Dolto Bau(4)	۸ D	V _{SW} =1.2V,	2.65		0.65		0
	$\Delta \mathbf{R}_{ON}$	I _{ON} =-10mA (Intra-pair)	2.05		0.05		12

Notes:

3. Measured by the voltage drop between A/B and CLK/Dn pins at the indicated current through the switch.

4. Guaranteed by characterization

DC ELECTRICAL CHARACTERISTICS, HIGH-SPEED MODE

(All typical values are $T_A = 25^{\circ}$ C, unless otherwise specified.)

PARAMETER	SYM	CONDITIONS	V _{cc} (V)	MIN	TYP	MAX	UNITS
HS Switch On Resistance ⁽⁵⁾	Ron	V _{SW} =0.4V,I _{ON} =-10mA	2.65		7	9.5	Ω
HS Delta R _{ON} ⁽⁶⁾	ΔR_{ON}	V _{SW} =0.4V, I _{ON} =-10mA (Intra-pair)	2.65		0.65		Ω

Notes:

5. Measured by the voltage drop between A, B, and Dn pins at the indicated current through the switch.

6. Guaranteed by characterization



AC ELECTRICAL CHARACTERISTICS

(All values are at R_L =50 Ω and R_S =50 Ω and all typical values are V_{CC}=2.775V at T_A=25°C unless otherwise specified.)

PARAMETER	SYM	CONDITIONS	V _{cc} (V)	MIN	TYP	MAX	UNITS
Off Isolation ⁽⁷⁾	Q_{IRR}	f=100MHz, R _T =50Ω	2.775		-35		dB
Non-Adjacent Channel	Vtolk		0.775		55		ЧD
Crosstalk ⁽⁷⁾	Alaik	1=10010102, RT=5002	2.775		-55		uр
Differential -3db Bandwidth ⁽⁷⁾	BW	CL=0pF, R_T =50 Ω	2.775		1.5		GHz
Turn-On Time	+		2 65 to 2 775		20	27	20
SEL, /OE to Output	LON	$C_L=\text{opr}, V_{SW}=1.2V$	2.05 10 2.775		20	57	115
Turn-Off Time	t		2 65 to 2 775		15	27	20
SEL, /OE to Output	LOFF	CL=5pr, vsw=1.2v	2.05 10 2.775		IJ	21	115
Propagation Delay ⁽⁷⁾	t _{PD}	C∟=5pF	2.775		0.25		ns
Brook Boforo Mako Timo	t	C _L =5pF	2 65 to 2 775	3	Б	Q	nc
	τввм	$V_{SW1}=V_{SW2}=1.2V$	2.05 10 2.775	3	5	0	115

Note:

7. Guaranteed by characterization.

AC ELECTRICAL CHARACTERISTICS

(All typical values are V_{CC}=2.775V at T_A=25°C unless otherwise specified.)

			· /				
PARAMETER	SYM	CONDITIONS	V _{cc} (V)	MIN	TYP	MAX	UNITS
Channel-to-Channel Skew	+	V _{SW} =0.2V diff _{PP} ,	0.775		40	00	50
Across Multiple Parts ^(8,9)	<pre>LSK(Part_Part)</pre>	C∟=5pF	2.775		40	00	ps
Channel-to-Channel Skew	+	V_{SW} =0.2V diff _{PP} ,	0.775		15	20	50
Within a Single Part ⁽⁸⁾	LSK(Chl-Chl)	C∟=5pF	2.775		15	30	ps
Skew of Opposite							
Transitions in the Same	t _{SK(Pulse)}	$v_{SW}=0.2v$ ullipp,	2.775		10	20	ps
Differential Channel ⁽⁸⁾		CL=opr					

Notes:

8. Guaranteed by characterization.

9. Assumes the same V_{CC} and temperature for all device.

CAPACITANCE

PARAMETER	SYM	CONDITIONS	V _{cc} (V)	MIN	TYP	MAX	UNITS
Control Pin Input	C	$\lambda_{1} = -0 \lambda_{1}$	0		15		
Capacitance ⁽¹⁰⁾	CIN	V CC=O V	0		1.5		ьE
Dn/CLK-On Capacitance ⁽¹⁰⁾	CON	/OE=0V, f=1MHz	2.775		7		рг
Dn/CLK Off Capacitance ⁽¹⁰⁾	COFF	/OE=2.775V, f=1MHz	2.775		2.5		

Note:

10. Guaranteed by characterization.

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TEST DIAGRAMS



Figure 4. On Resistance



Figure 6. AC Test Circuit Board



Figure 8. Propagation Delay(t_Rt_F-500ps)





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**Each switch port is tested separately

Figure 5. Off Leakage



Figure 7. Turn-On/Turn-Off waveform



Figure 9. Channel to Channel Skew



Figure 11. Channel On Capacitance



TEST DIAGRAMS(CONTINUED)















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PACKAGE OUTLINE DIMENSIONS



Remark:

Lead Finish:NiPdAu

Figure 16. 24-Lead QFN(2.5mm x 3.4mm) Package



RECOMMEDNED PCB LAYOUT PATTERN (UNIT:mm)



单击下面可查看定价,库存,交付和生命周期等信息

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